

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Shintaro SHINKAWA et al. Group Art Unit : Not Yet Assigned

Appl. No. : 10/563,423 (U.S. National Stage of PCT/JP2004/009798)

J.A. Filed : July 9, 2004 Examiner : Not Yet Assigned

For : ULTRASONIC WELDING APPARATUS, INFORMATION RECORDING MEDIUM MANUFACTURING APPARATUS, ULTRASONIC WELDING METHOD, OBJECT, AND CARTRIDGE CASE



INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir :

In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and §§1.97-1.98, Applicants hereby bring the following information to the attention of the Examiner in charge of the above-identified application, which includes information cited and discussed in the specification and the International Search Report issued in connection with International Patent Application No. PCT/JP2004/009798, of which the present application is the U.S. National Stage Application. A copy of the International Search Report was enclosed with the papers when entering the U.S. National Stage on January 5, 2006. The Examiner is invited to review these materials to inspect the relevance indicated

during international examination with respect to the documents cited therein.

The following is a list of the documents cited in the above-noted documents:

Japanese Laid-open Patent Publication No. HEI 11-176132, together with an English language abstract of the same. Applicants note that this document is cited on page 2 of the specification of the present application;

Japanese Laid-open Patent Publication No. SHO 48-23646, together with an English language translation of the passage deemed relevant in the International Search Report;

Japanese Laid-open Patent Publication No. 2001-1161, together with an English language abstract of the same;

Japanese Laid-open Patent Publication No. HEI 11-104859, together with an English language abstract of the same;

Japanese Laid-open Patent Publication No. 2003-109354, together with an English language abstract of the same and patent family member U.S. Patent Application Publication No. 2002/0195474; and

Japanese Laid-open Patent Publication No. SHO 52-41311, together with an English language translation of the passage deemed relevant in the International Search Report.

Applicant also call to the Examiner's attention the following documents:

U.S. Patent Application Publication No. 2005/0274839; and

U.S. Patent Application Publication No. 2005/0263638.

Further to 37 C.F.R. §1.98 (a)(2)(ii), copies of the U.S. patent application publications are not enclosed herewith. However, if copies are needed, the Examiner is respectfully requested to contact the undersigned.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto and all of the above-noted documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicants note that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

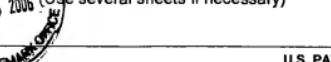
Respectfully Submitted,
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FORM PTO-1449		U.S. Department of Commerce Patent and Trademark Office			Atty. Docket No. P29100	Application No. 10/563,423	
					Applicant Shintaro SHINKAWA et al.		
					Filing Date July 9, 2004	Group Not Yet Assined	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/N.D./	2005	0 2 7 4 8 3 9	12/15/05	SASAKI et al.			
/N.D./	2005	0 2 6 3 6 3 8	12/01/05	SASAKI et al.			
/N.D./	2002	0 1 9 5 4 7 4	12/26/02	TSUYUKI et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/N.D./	11	- 1 7 6 1 3 2	07/02/99	JAPAN			
↓	48	- 2 3 6 4 6	03/27/73	JAPAN			x
	2001	- 1 1 6 1	01/09/01	JAPAN			
↓	11	- 1 0 4 8 5 9	04/20/99	JAPAN			
	2003	- 1 0 9 3 5 4	04/11/03	JAPAN			
/N.D./	52	- 4 1 3 1 1	10/18/77	JAPAN			x
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
/N.D./	1	English language Abstract of JP 11-176132.					
/N.D./	2	English language Abstract of JP2001-1161.					
/N.D./	3	English language Abstract of JP11-104859.					
/N.D./	4	English language Abstract of JP2003-109354.					
EXAMINER		/Nicholas D'aniello/		DATE CONSIDERED		03/25/2008	
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /N.R./